On the properties of surface reconstructed silicon nanow ires

R Ruralix and N Lorente

Laboratoire Collisions, Agregats, Reactivite, IRSAMC, Universite Paul Sabatier, 118 route de Narbonne, 31062 Toulouse cedex, France

Abstract.

We study by means of density-functional calculations the role of lateral surface reconstructions in determining the electrical properties of hl00i silicon nanowires. The dierent lateral reconstructions are explored by relaxing all the nanowires with crystalline bulk silicon structure and all possible ideal facets that correspond to an average diameter of $1.5~\rm nm$. We show that the reconstruction induces the formation of ubiquitous surface states that turn the wires into sem i-m etallic or m etallic.

1. Introduction

There has been a growing interest in semiconductor nanowires [1, 2, 3] for their potential use in future nanoelectronic applications, such as nanocontacts and nanoswitches. Silicon nanowires (SiNW s) are especially attractive for their possible e-cient integration in conventional Si-based microelectronics. The use of SiNW s as chemical sensors has also been demonstrated. SiNW -based sensors for the detection of NH [4], of biological macromolecules [5] and for the identication of complementary vs. mismatched DNA [6] have been reported. Experimentally, SiNW s are grown from a nanocrystal [2, 7] which is used as a seed to direct the one-dimensional crystallisation of silicon. The (typically gold) nanocluster serves as the critical point for nucleation and enables the addition of reactants that allow the growth, determining the nanowire diameter and orientation. Maetal [8] achieved the thinnest SiNW s reported so far, with diameters as small as 1.3 nm for a wire grown along the hl10i direction. A few other groups [7, 9, 10] also obtained SiNW s with diameters below 10 nm and growth orientations including hl00i [7], hl10i [7, 9], hl11i [9] and hl12i [9].

The one-dimensionality is known to induce a gap broadening e ect, due to quantum con nement, in H-passivated SiNW s [11]. In this paper we explore on theoretical grounds the electronic structure of SiNW s when the lateral surface is left free to reconstruct. Silicon surfaces are among the most studied system s of the latest decades, both theoretically and experimentally, and it is well-known that the reconstruction drastically a ects their electronic properties. In Section 3.1 we discuss the geometry of

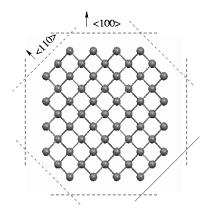


Figure 1. Facet arrangement of a $h100i\ SiNW$ as dictated by the W ul's rule. The formation of f110g facets allows a smoother matching between f100g facets.

the surface reconstructed SiNW s considered and the implication of the W ul 's rule in the case nanoscale one-dimensional systems. In Section 32 we analyse the electronic structure of the most favoured reconstruction and the localisation of the surface states that have been found to form.

2. Com putational m ethods

The calculations presented in this paper have been carried out in the fram ework of density-functional theory (DFT). We have used both a numerical atom ic orbital [12] and a plane-wave [14] basis set. We have used a double—polarised basis set [12] with pseudopotentials of the Troullier-Martins [13] type and a plane-wave energy cuto of 20 Ry [14] with ultrasoft pseudopotentials [15]. In both cases the exchange-correlation energy was calculated according to the Generalised Gradient Approximation [16]. The wires that we have studied have a diameter of 1.5 nm and a number of atoms ranging from 57 to 171, depending on the supercell size and on the adopted shape of the unrelaxed wire section. The Brillouin zone has been sampled according to the Monkhorst-Pack [17] scheme with a converged grid of 1 1 4, 1 1 6 or 1 1 12 k-points, depending on the supercell size.

3. Results and discussion

3.1. Structural relaxations: checking the W ul 's rule at the nanoscale

Convincing experimental evidence shows that SiNWs are constructed around a crystalline bulk core [8, 18]. The shape of the section of such a structure will depend on the way in which the involved vicinal surfaces match and on how abrupt is the transition from one to the other. The case of SiNWs grown along the h100i direction is of especial interest, because it determines a rather conjective situation at the edges where two (100) surfaces meet with a 90 angle [see Figure 1 and 2 (c)]. In such conditions, it is known

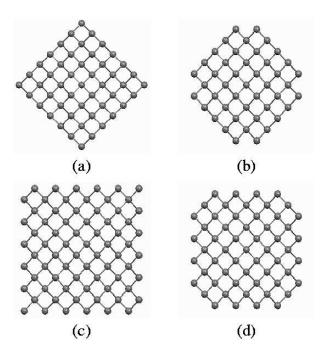


Figure 2. Unrelaxed section of the SiNW s considered.

from Wul's theorem [19] that the form ation of a facet is to be expected, because it would partly release the stress accumulated at the edge. An example of faceting of a h100i SiNW [20, 21] is shown in Figure 1. As can be seen, the formation of a f110g facet allows a much smoother transition between the two vicinal (100)—like surfaces. However, as discussed previously by Zhang and Yakobson [22], in the case of very thin one-dimensional structures such as those that we are treating, the predictions of Wul's rule should be carefully revised. The size of the f110g and of the f100g facets are of the same order of magnitude, thus the surface energy associated to the edges can no longer be neglected, as assumed in Wul's rule. For these reasons, the rst part of this work has consisted in identifying the favoured faceting arrangement of h100i SiNW of nanometric thickness, thus verifying the validity of Wul's theorem in these conditions.

We have considered two dierent square-section wires Figure 2(a) and (c)] and two Wul faceting arrangements Figure 2(b) and (d)]. The square wire of Figure 2(a) is made of f110g facets, while the wire in Figure 2(c) has only f100g facets. The wires of Figure 2(b) and (d) have been obtained from those of Figure 2(a) and (c), respectively, smoothening the corners according to Wul's rule prescription. The way in which the tension at the edges is released and the way in which the dierent Si surface reconstructions (f100g and f110g facets) compete among them will determ ine the minimum energy structure. Therefore, given the starting con gurations of Figure 2, very dierent minimum energy structures are expected.

The results of the relaxations are shown in the section-view of Figure 3. As can be seen, all but one of the wires maintain a high degree of in-plane symmetry. As expected, in the SiNW of Figure 3 (a) f110g facets are dominant. The same relaxation pattern is

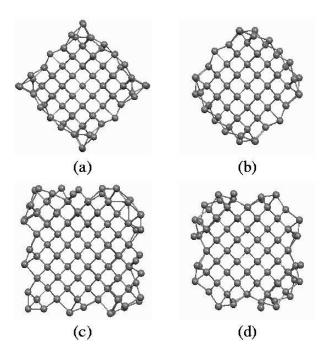


Figure 3. Relaxed section of the SiNW s considered.

followed by the wire of Figure 3 (b), with the only notable exception of the missing corner atoms, whose removal allow a smoother match between the vicinal (110)—like surfaces. In accordance to the prediction of Wul's rule, the SiNW of Figure 3 (b) turned out to be more stable than that of Figure 2 (a) (the dierence amounting to 33 meV/atom).

In the relaxation of the SiNW s of Figure 3(c) and (d) f100g facets prevail. It is interesting to note that in this case the e ects of a Wul-like pro le are more evident than in the former case. Here an actual edge-faceting develops, mediating the transition between the vicinal (100)-like surfaces by f110g facets [see Figure 3(d)]. On the other hand, when the edges between the f100g facets are not smoothened, the wire favours a symmetry breaking, ending up with the butter y-shaped section of Figure 3(c). Interestingly enough, the butter y wire of Figure 3(c) has turned out to be slightly more stable than the wire of Figure 3(d), thus con ming that at such small diameters the validity of Wul 's rule should be carefully checked.

Regarding the in uence of facet orientation, we have found that wires dom inated by f100g facets [Figure 3 (c) and (d)] are more stable than those where f110g facets prevail [(Figure 3 (a) and (b))]. The cohesive energies are summarised in Table 1. For these reasons, the candidate structures for SiNW s grown along the f100g direction appear to be those in Figure 3 (c) and (d), favouring the form ation of f100g over f110g facets.

We have found that for the SiNW of Figure 3(d) two dierent reconstructions of the f100g facets are possible [21]. Like in the case of the in nite Si(100) surface, the reconstruction consists in the formation of a sequence of buckling dimers. What diers between the two competing geometries that we have obtained is the pattern followed by the Sidimers. In one case they determine a trough in the middle of the facet, while

D om inant facets	Section shape	Cohesive energy (eV/atom)
h110i	square	3.886
h110i	Wul	3.919
h100i	square	4.006
h100i	Wul	3.989

Table 1. Cohesive energies per atoms of the SiNW type illustrated in Fig. 3. The SiNW swhere f100g facets prevail are approximately 0.1 eV/atom more stable.

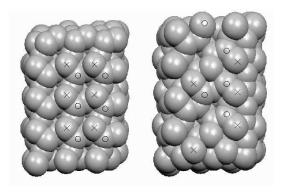


Figure 4. M in im um energy geometries for the facets of h100i butter y-like SiNW of Figure 3(d).

in the other one every two dimers on one of the two sides is ipped with respect to the symmetric behaviour of the trough reconstruction. The relaxed geometry of the facets of the butter ywire is shown in Figure 4. The symmetry breaking is rejected in the relaxation and the f100g facets follows two different relaxation patterns. One of them—Figure 4(a)—is rather symmetric, with all the dimers of one side ipped; the facet of Figure 4(b) presents a regular sequence of buckled dimers only in one of the two sides, while in the other one every two dimers is missing.

3.2. Electronic structure

Nanowires - and SiNW s in particular - are expected to play an important role in future molecular electronics applications. Therefore, a thorough understanding of their conductive properties is required. In this section we discuss our results of the electronic structure of the butter ywire Figure 3 (c)], as well as of the two dierent reconstructions that we have found for the Wul-like SiNW Figure 3 (d)].

In Figure 5(a) and (b) the band structure diagrams corresponding to the two competing geometries for the Wul-like wire are displayed. It is somehow surprising to discover that they are rather dierent: while the trough reconstruction is strongly metallic, with four bands crossing the Fermilevel, the ipped dimer geometry is only semi-metallic, with one band approaching the Fermilenergy with a zero derivative at the zone boundary. This is quite striking, at rst sight, because the dierences between the

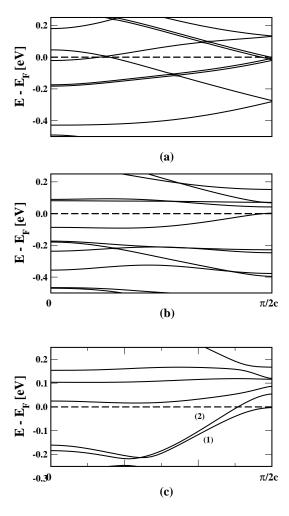
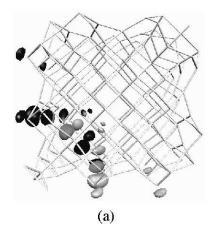


Figure 5. Band structure diagrams of (a) the trough and (b) the dimer ipped reconstruction of the SiNW with a Wul-like section; (c) the butter y-like SiNW.

two reconstructions do not seem to be so relevant. However, when considered in more detail, one notices the pivotal role that the ipped dimer has in breaking the surface Bloch state that would otherwise form. On the contrary, the surface state forms in the trough reconstruction where all the Sidimers follow the same buckling pattern.

The band structure of the butter y wire is shown in Figure 5(c). Also in this case the reconstruction results in a metallisation of the wire surface, with one band crossing the Ferm i level and a sem immetallic band tangent to it at the zone boundary. The formation of these metallic and sem immetallic states is directly induced by the reconstruction of the surface dimers. Therefore, they are expected to be localised at the wire's outer layers. The dimerisation leads to a dangling bond that hybridises with the other dimers' dangling bonds along the nanowire in a surface—bond. The surface nature of the sem immetallic and metallic states of Figure 5(c) is evident in Figure 6 where we have plotted the corresponding wave functions. As can be seen, the metallic and sem immetallic state are localised, at opposite sides, along one of the h110i diagonal. A similar surface localisation, though more symmetric, following the pattern of the



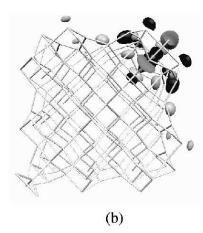


Figure 6. W ave function of (a) the sem i-m etallic and (b) m etallic state, respectively labelled as (1) and (2) in Figure 5 (c).

overall relaxed geom etry, is observed for the W ul -like SiNW of Figure 3 (d) (not shown here; see Reference [21]). Therefore, conduction in surface-reconstructed SiNW s will be almost entirely sustained by the outer layers of the wire, with a negligible penetration inside the wire's core. These results, i.e. metallic or sem i-metallic nature and surface character of the conduction channels, concern all of the h100i wire types that are likely to be obtained. As we have discussed in Section 3.1 (see also Table 1), the difference of cohesive energies among the favoured wire geometries [the wire of Figure 3 (c) and the two reconstructions of Figure 3 (d)] are very small and the selective growth of one or another wire seems a difficult task.

4. Conclusions

We have shown that in absence of a proper passivation, the lateral surface of SiNW s strongly reconstructs, form ing series of buckled dimers with a pattern similar to Si (100) surfaces. Depending on the reconstruction, surface states that cross the Fermi level can form, leading to metallic or semimetallic SiNW s. Under such circum stances, doping is no longer needed to have highly conducting nanowires. The possibility of tailoring SiNW s that are conducting without the need of doping is particularly relevant in very thin wires where typical doping concentrations require a precision in the fraction of impurities per atom extremely discult to control.

A vailable experiments have not thoroughly explored the possibility of surface reconstruction or nanowire conductance without doping. However, these results show a promising venue of experimental and theoretical research of pure SiNW s.

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